

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10577924	NAKAMURA ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	SISAY YACOB	2612

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
340	541, 540+, 545.1+, 5.1+, 7.1+, \$.ccls.	03/23/2008	S.Y.
382	115	03/23/2008	S.Y.

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Searched EAST: US-PGPUB; SUPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	03/23/2008	S.Y.
Searched: PLUS; GOOGLE	03/23/2008	S.Y.
Inventors Name Search: NAKAMURA-AKIHIKO.inv.; OYAGI-MASAYUKI.inv.; YAMATO-MASAKI.inv.; HISANO-ATSUSHI.inv.; HISANO-ATSUSHI.inv.	03/23/2008	S.Y.

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
Same as	above	03/23/2008	S.Y.